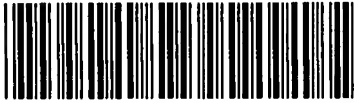


Search Notes

Application/Control No.

10/601,496

Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

OZAWA, TAKESHI

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search		9/11/2007	AL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/168 (limited to text search)	9/4/2006	AL
382/128-134, 168 limited to text search	9/11/2007	AL
356/146,337-343,411 limited to text search	9/11/2007	AL